# FAIRCHILD

SEMICONDUCTOR

# 74F86 2-Input Exclusive-OR Gate

### **General Description**

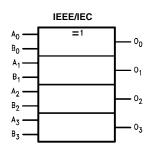
This device contains four independent gates, each of which performs the logic exclusive-OR function.

## **Ordering Code:**

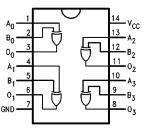
Order Number	Package Number	Package Description
74F86SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74F86SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F86PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### Logic Symbol



# **Connection Diagram**



## Unit Loading/Fan Out

Pin Names	nes Description U.L. HIGH/LOW		Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>	
A <sub>n</sub> , B <sub>n</sub>	Inputs	1.0/1.0	20 µA/–0.6 mA	
On	Outputs	50/33.3	–1 mA/20 mA	

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74F86

#### Absolute Maximum Ratings(Note 1)

	-
Storage Temperature	-65°C to +150°C
Ambient Temperature under Bias	-55°C to +125°C
Junction Temperature under Bias	-55°C to +150°C
V <sub>CC</sub> Pin Potential to Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30 mA to +5.0 mA
Voltage Applied to Output	
in HIGH State (with $V_{CC} = 0V$ )	
Standard Output	–0.5V to V <sub>CC</sub>
3-STATE Output	-0.5V to +5.5V
Current Applied to Output	
in LOW State (Max)	twice the rated $I_{OL}$ (mA)

#### **Recommended Operating** Conditions

Free Air Ambient Temperature Supply Voltage

 $0^{\circ}C$  to  $+70^{\circ}C$ +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

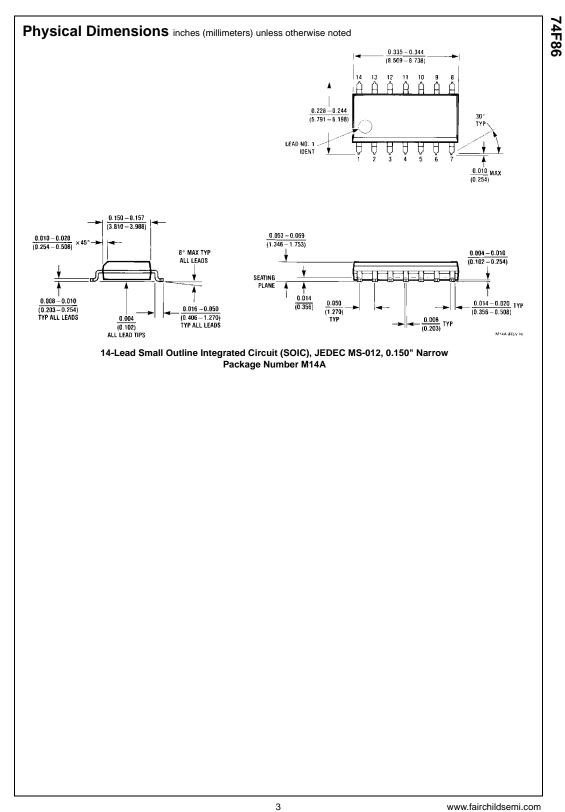
### **DC Electrical Characteristics**

Symbol	Paramete	r	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltag	e			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage 10% V <sub>C</sub>		2.5			v	Min	I <sub>OH</sub> = -1 mA
		5% $V_{CC}$	2.7			v	IVIIN	$I_{OH} = -1 \text{ mA}$
V <sub>OL</sub>	Output LOW Voltage	10% V <sub>CC</sub>			0.5		Min	I <sub>OL</sub> = 20 mA
IIH	Input HIGH Current				5.0	μΑ	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current Break	down Test			7.0	μΑ	Max	V <sub>IN</sub> = 7.0V
I <sub>CEX</sub>	Output HIGH Leakage Cu	irrent			50	μΑ	Max	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage Test		4.75			V	0.0	I <sub>ID</sub> = 1.9 μA
								All other pins grounded
I <sub>OD</sub>	Output Leakage Circuit Current				3.75	μA	0.0	V <sub>IOD</sub> = 150 mV
					3.75	μΑ		All other pins grounded
IIL	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$
I <sub>OS</sub>	Output Short-Circuit Curre	ent	-60		-150	mA	Max	$V_{OUT} = 0V$
I <sub>CCH</sub>	Power Supply Current			12	18	mA	Max	V <sub>O</sub> = HIGH
I <sub>CCL</sub>	Power Supply Current			18	28	mA	Max	$V_{O} = LOW$

### **AC Electrical Characteristics**

Symbol	Parameter	T <sub>A</sub> = +25°C V <sub>CC</sub> = +5.0V C <sub>L</sub> = 50 pF			$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay	3.0	4.0	5.5	3.0	6.5	
t <sub>PHL</sub>	A <sub>n</sub> , B <sub>n</sub> to O <sub>n</sub> (Other Input LOW)	3.0	4.2	5.5	3.0	6.5	ns
t <sub>PLH</sub>	Propagation Delay	3.5	5.3	7.0	3.5	8.0	
t <sub>PHL</sub>	A <sub>n</sub> , B <sub>n</sub> to O <sub>n</sub> (Other Input HIGH)	3.0	4.7	6.5	3.0	7.5	ns

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